

ABSTRACT

A micro terminal for inspection or installation with high connection reliability is provided at lower cost. A micro terminal (91) according to the present invention has electrical conduction between the micro terminal and an electrode of an electronic device or an inspection device and includes a columnar contactor (91a, 91c) in contact with the electrode. The contactor (91a, 91c) has a spring structure which is elastically deformed when pressed against the electrode. The contactor (91a, 91c) includes a protrusion (1t) protruding outwardly at its end in contact with the electrode and the shape of the protrusion (1t) has a part of a sphere or a part of a paraboloid of revolution.